

1. Global joint venture starts operations as WeEn Semiconductors

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WeEn Semiconductors



Product data sheet

1. General description

Dual ultrafast power diode in a SOT429 (3-lead TO-247) plastic package.

2. Features and benefits

- Very low on-state loss
- Fast switching
- Soft recovery characteristic minimizes power consuming oscillations
- High thermal cycling performance
- Low thermal resistance

3. Applications

Output rectifiers in high-frequency switched-mode power supplies

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{RRM}	repetitive peak reverse voltage		-	-	400	V
I _{F(AV)}	average forward current	δ = 0.5 ; T _{mb} ≤ 104 °C; square-wave pulse; per diode; <u>Fig. 1</u> ; <u>Fig. 2</u> ; <u>Fig. 3</u>	-	-	15	А
I _{O(AV)}	average output current	δ = 0.5 ; T _{mb} ≤ 94 °C; square-wave pulse; both diodes conducting	-	-	30	А
Static chara	acteristics					
V _F	forward voltage	I _F = 15 A; T _j = 150 °C; <u>Fig. 6</u>	-	0.95	1.12	V
Dynamic ch	naracteristics		'			,
t _{rr}	reverse recovery time	$I_F = 1 \text{ A}$; $V_R = 30 \text{ V}$; $dI_F/dt = 100 \text{ A/}\mu\text{s}$; $T_j = 25 \text{ °C}$; Fig. 7	-	35	60	ns





Dual ultrafast power diode

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	A1	anode 1		A1 A2
2	K	cathode		
3	A2	anode 2		sym125
mb	К	mounting base; cathode		
			TO-247 (SOT429)	

6. Ordering information

Table 3. Ordering information

Type number	Package				
	Name	Description	Version		
BYV74W-400	TO-247	plastic single-ended through-hole package; heatsink mounted; 1 mounting hole; 3 lead TO-247	SOT429		

7. Marking

Table 4. Marking codes

Type number	Marking code
BYV74W-400	BYV74W-400

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{RRM}	repetitive peak reverse voltage		-	400	V
V _{RWM}	crest working reverse voltage		-	400	V
V _R	reverse voltage	T _{mb} ≤ 136 °C; DC	-	400	V
I _{F(AV)}	average forward current	δ = 0.5 ; T _{mb} ≤ 104 °C; square-wave pulse; per diode; <u>Fig. 1</u> ; <u>Fig. 2</u> ; <u>Fig. 3</u>	-	15	A
I _{O(AV)}	average output current	δ = 0.5 ; T _{mb} ≤ 94 °C; square-wave pulse; both diodes conducting	-	30	А

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Symbol	Parameter	Conditions	Min	Max	Unit
I _{FSM}	non-repetitive peak forward current	t_p = 10 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; per diode; Fig. 4	-	170	Α
		t_p = 8.3 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; per diode; Fig. 4	-	185	Α
T _{stg}	storage temperature		-40	150	°C
T _j	junction temperature		-	150	°C

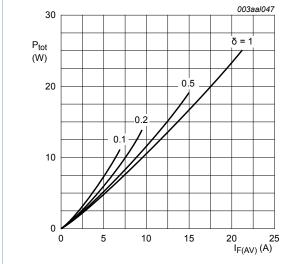


Fig. 1. Forward power dissipation as a function of average forward current; square waveform; per diode; maximum values

$$\begin{split} I_{F(AV)} &= I_{F(RMS)} \times \sqrt{\delta} \\ V_{O} &= 0.959 \text{ V; } R_{S} = 0.010 \text{ } \Omega \end{split}$$

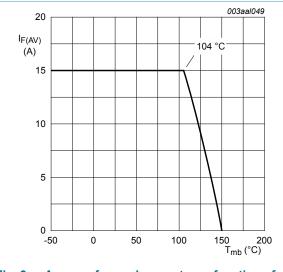


Fig. 3. Average forward current as a function of mounting base temperature; per diode; maximum values

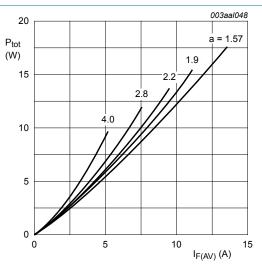


Fig. 2. Forward power dissipation as a function of average forward current; sinusoidal waveform; per diode; maximum values

a = form factor =
$$I_{F(RMS)}/I_{F(AV)}$$

 V_{O} = 0.959 V; R_{S} = 0.010 Ω

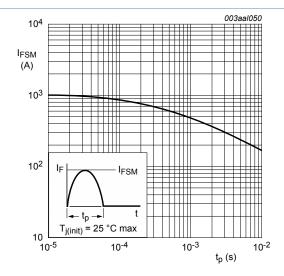


Fig. 4. Non-repetitive peak forward current as a function of pulse width; sinusoidal waveform; per diode; maximum values

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Dual ultrafast power diode

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to	with heatsink compound; per diode; Fig. 5	-	-	2.4	K/W
	mounting base	with heatsink compound; both diodes conducting	-	-	1.4	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	in free air	_	45	-	K/W

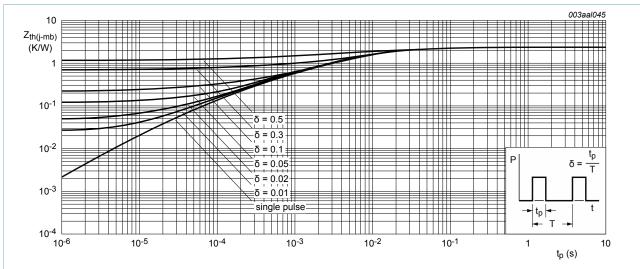


Fig. 5. Transient thermal impedance from junction to mounting base as a function of pulse width; per diode; maximum values

10. Characteristics

Table 7. Characteristics

characteristics are per diode unless otherwise stated

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Static characteristics							
V _F	forward voltage	I _F = 15 A; T _j = 25 °C; <u>Fig. 6</u>		-	1.08	1.25	V
		I _F = 30 A; T _j = 25 °C; <u>Fig. 6</u>		-	1.15	1.36	V
		I _F = 15 A; T _j = 150 °C; <u>Fig. 6</u>		-	0.95	1.12	V
I _R reverse current		V _R = 400 V; T _j = 25 °C		-	10	50	μA
		V _R = 400 V; T _j = 100 °C		-	0.3	8.0	mA

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Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Dynamic characteristics							
Q _r	recovered charge	$I_F = 2 \text{ A}$; $V_R = 30 \text{ V}$; $dI_F/dt = 20 \text{ A/}\mu\text{s}$; $T_j = 25 \text{ °C}$; Fig. 7		-	40	60	nC
t _{rr}	reverse recovery time	$I_F = 1 \text{ A}$; $V_R = 30 \text{ V}$; $dI_F/dt = 100 \text{ A/µs}$; $T_j = 25 \text{ °C}$; Fig. 7		-	35	60	ns
I _{RM}	peak reverse recovery current	$I_F = 10 \text{ A}$; $V_R = 30 \text{ V}$; $dI_F/dt = 50 \text{ A/µs}$; $T_j = 100 \text{ °C}$; Fig. 7		-	4.2	5.2	A
V_{FRM}	forward recovery voltage	$I_F = 10 \text{ A}$; $dI_F/dt = 10 \text{ A/}\mu\text{s}$; $T_j = 25 \text{ °C}$; Fig. 8		-	2.5	-	V

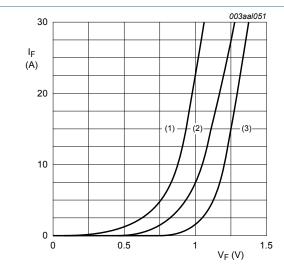


Fig. 6. Forward current as a function of forward voltage; per diode

(1) $T_j = 150$ °C; typical values;

(2) T_i = 150 °C; maximum values;

(3) $T_j = 25$ °C; maximum values; $V_O = 0.959 \text{ V}; R_S = 0.010 \Omega$

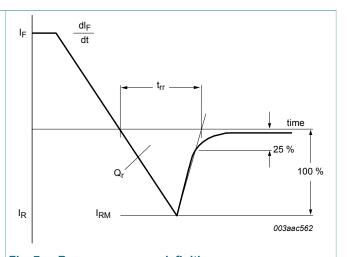
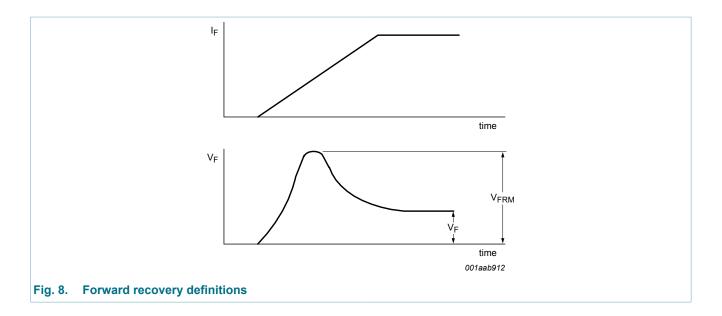


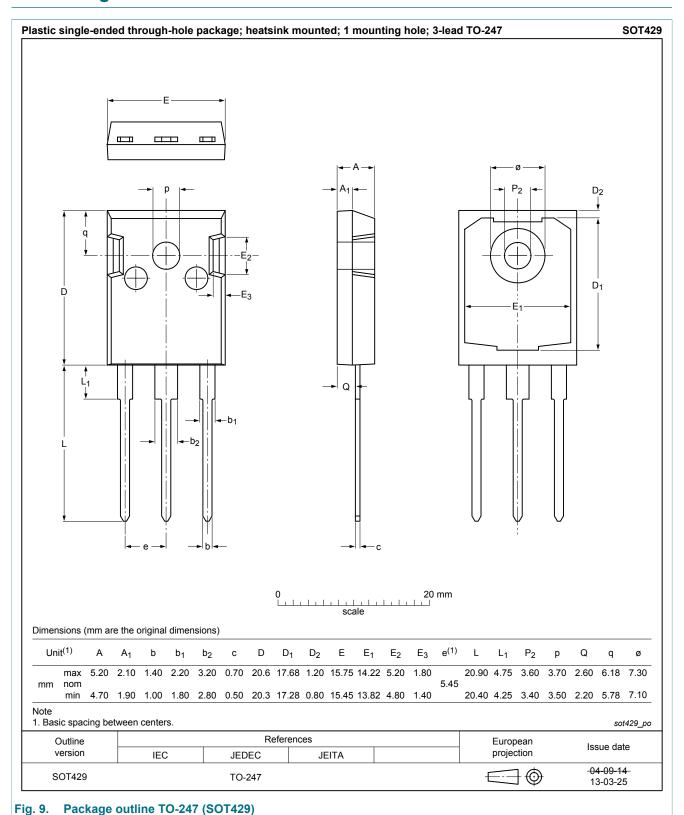
Fig. 7. Reverse recovery definitions; ramp recovery

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11. Package outline



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12. Legal information

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Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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